

# **MOSFET** - Power, Single N-Channel, Source Down, WDFN9

## 40 V, 2.1 mΩ, 150 A NTTFSS002N04HL

#### **Features**

- Advanced Source–Down Package Technology (3.3x3.3mm) with Excellent Thermal Conduction
- Ultra Low R<sub>DS(on)</sub> to Improve System Efficiency
- Low Q<sub>G</sub> and Capacitance to Minimize Driving and Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Typical Applications**

- DC-DC Switching Applications
- ORing Applications
- Power Load Switch
- Battery Management and Protection

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

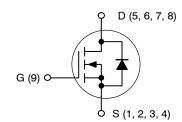
Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	40	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	150	Α
Current R <sub>θJC</sub> (Note 1)	Steady	T <sub>C</sub> = 85°C		107	
Power Dissipation R <sub>θJC</sub> (Note 1)	State	T <sub>C</sub> = 25°C	P <sub>D</sub>	84	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	23	Α
Current R <sub>0JA</sub> (Notes 1, 2)	Steady	T <sub>A</sub> = 85°C		16	
Power Dissipation R <sub>θJA</sub> (Notes 1, 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	2	W
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	900	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 49 A, L = 0.1 mH)			E <sub>AS</sub>	96	mJ
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

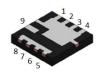
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- The entire application environment impacts the thermal resistance values shown, they are not constants and are valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 1 in<sup>2</sup> pad size, 1 oz Cu pad.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
40 V	2.1 mΩ @ 10 V	150 A	
40 V	3.1 mΩ @ 4.5 V	150 A	

#### NMOS





#### WDFN9 CASE 511EB

#### MARKING DIAGRAM



2N04L= Specific Device Code

A = Assembly Location

WL = Wafer Lot Y = Year WW = Work Week

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 5 of this data sheet.

#### THERMAL RESISTANCE RATINGS

Parameter		Max	Unit
Junction-to-Case - Steady State (Note 1)	$R_{ heta JC}$	1.48	°C/W
Junction-to-Ambient - Steady State (Note 1, 2)	$R_{\theta JA}$	60	

#### **ELECTRICAL CHARACTERISTICS** (T<sub>1</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS						•	•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>	I <sub>D</sub> = 250 μA, ref to 25°C			8		mV/°C
Zero Gate Voltage Drain Current	$I_{DSS}$ $V_{GS} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$		T <sub>J</sub> = 25°C			10	μΑ
		V <sub>DS</sub> = 32 V				100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V				100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 120 μA	1.2		2.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	I <sub>D</sub> = 120 μA, re	ef to 25°C		-5.6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 23 A		1.77	2.10	mΩ
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 18 A		2.52	3.10	
Gate Resistance	$R_{G}$	T <sub>A</sub> = 25	°C		0.85		Ω
CHARGES & CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 20 V, f = 1 MHz			2760		pF
Output Capacitance	C <sub>OSS</sub>				655		
Reverse Capacitance	C <sub>RSS</sub>				43		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 20 V; I <sub>D</sub> = 18 A			20.3		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				2.5		
Gate-to-Drain Charge	$Q_{GD}$				8.4		]
Gate-to-Source Charge	Q <sub>GS</sub>				6.0		1
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 20 V; I <sub>D</sub> = 18 A			43		
SWITCHING CHARACTERISTICS, $V_{GS}$ =	= 10 V (Note 3)						
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 10 V, $V_{DD}$ = 20 V, $I_{D}$ = 23 A, $R_{G}$ = 2.5 $\Omega$			12.6		ns
Rise Time	t <sub>r</sub>				10		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				36.6		1
Fall Time	t <sub>f</sub>				6.8		1
SOURCE-TO-DRAIN DIODE CHARACT	ERISTICS						
Forward Diode Voltage	$V_{SD}$ $V_{GS} = 0 V$ , $T_{J} = 2$	T <sub>J</sub> = 25°C		0.78	1.2	V	
		.407	T <sub>J</sub> = 125°C		0.63		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0$ V, dl/dt = 100 A/ $\mu$ s, $I_S = 23$ A			35.8		ns
Reverse Recovery Charge	$Q_{RR}$				26.6		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

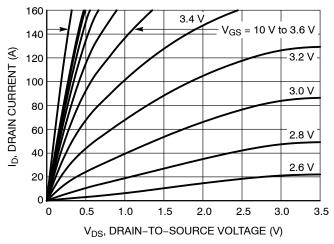


Figure 1. On-Region Characteristics

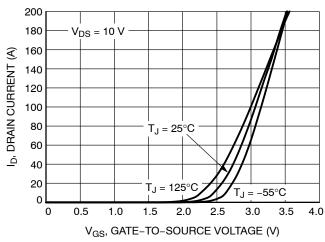


Figure 2. Transfer Characteristics

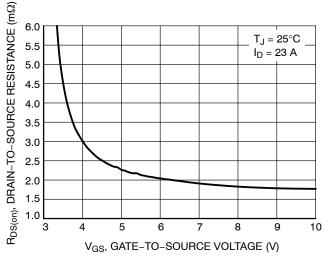


Figure 3. On-Resistance vs. Gate-to-Source Voltage

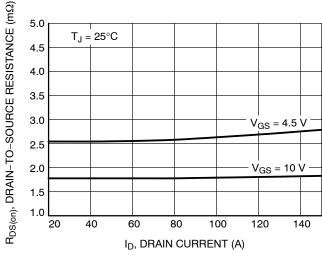


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

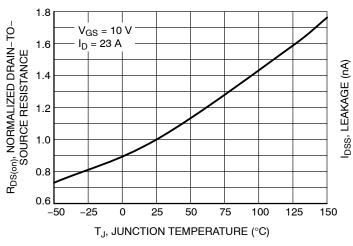


Figure 5. On–Resistance Variation with Temperature

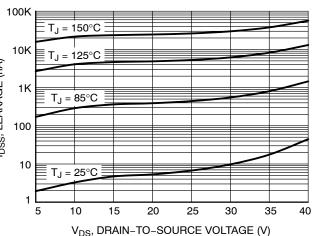


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

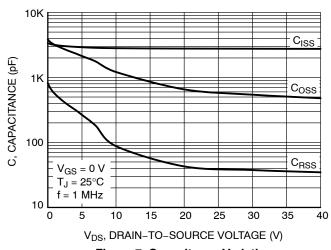


Figure 7. Capacitance Variation

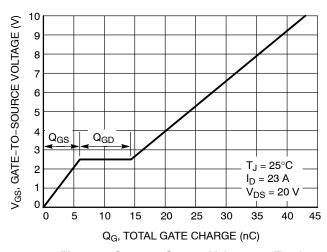


Figure 8. Gate-to-Source Voltage vs. Total Charge

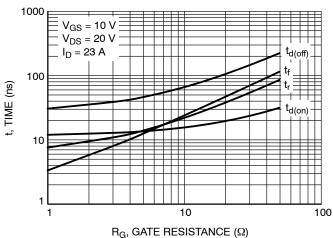


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

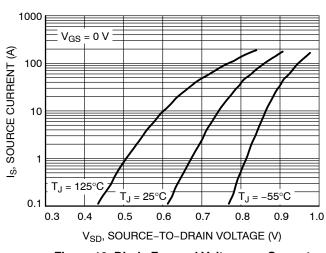


Figure 10. Diode Forward Voltage vs. Current

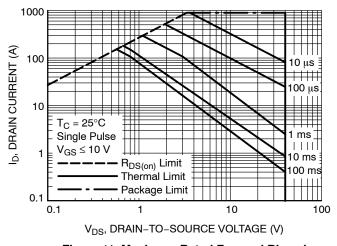


Figure 11. Maximum Rated Forward Biased Safe Operating Area

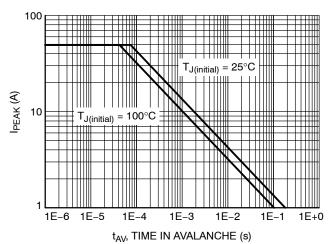


Figure 12. Maximum Drain Current vs. Time in Avalanche

#### **TYPICAL CHARACTERISTICS**

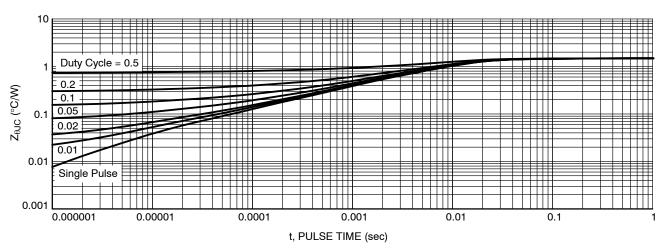


Figure 13. Transient Thermal Impedance

#### **ORDERING INFORMATION**

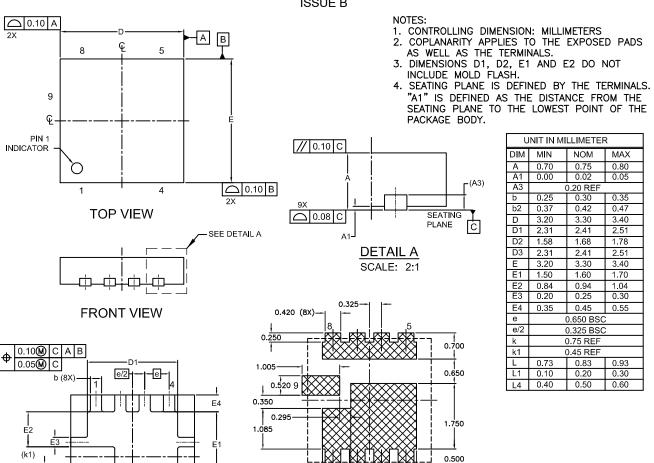
Device	Marking	Package	Shipping <sup>†</sup>
NTTFSS002N04HL	2N04L	WDFN9 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### **PACKAGE DIMENSIONS**

#### WDFN9 3.3x3.3, 0.65P

CASE 511EB **ISSUE B** 



9b2

8

-D3 **BOTTOM VIEW** 

UNIT IN MILLIMETER						
DIM	MIN	NOM	MAX			
Α	0.70	0.75	0.80			
A1	0.00	0.02	0.05			
А3		0.20 REF				
b	0.25	0.30	0.35			
b2	0.37	0.42	0.47			
О	3.20	3.30	3.40			
D1	2.31	2.41	2.51			
D2	1.58	1.68	1.78			
D3	2.31	2.41	2.51			
Е	3.20	3.30	3.40			
E1	1.50	1.60	1.70			
E2	0.84	0.94	1.04			
E3	0.20	0.25	0.30			
E4	0.35	0.45	0.55			
е	0.650 BSC					
e/2	0.325 BSC					
k	0.75 REF					
k1	0.45 REF					
L	0.73	0.83	0.93			
L1	0.10	0.20	0.30			

0.50

0.60

L4 0.40

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

LAND PATTERN RECOMMENDATION

0.755

-0.650

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